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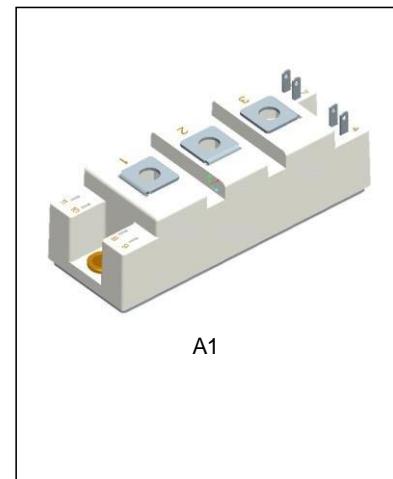
75A, 1200V IGBT MODULE

DESCRIPTION

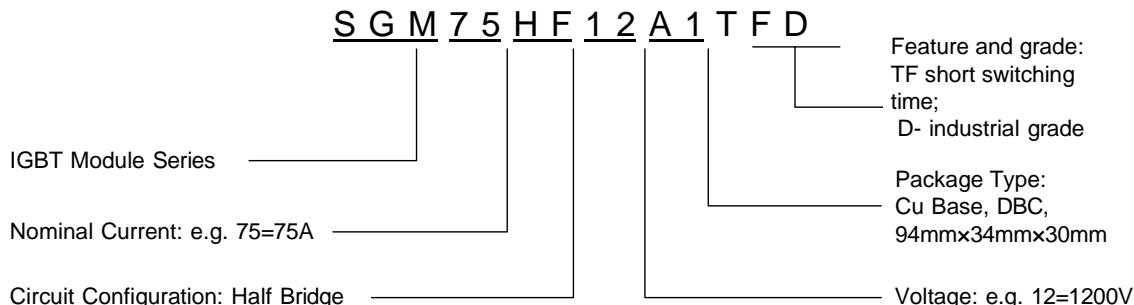
SGM75HF12A1TFD Module offers the optimum performance for UPS, AC inverter drive and electronic welders.

FEATURES

- 75A, 1200V, $V_{CE(sat)(typ.)} = 2.2V @ I_C = 75A$
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- Low switching loss
- Isolated copper baseplate using DBC technology



NOMENCLATURE





ORDERING INFORMATION

Part No.	Package	Marking	Packing
SGM75HF12A1TFD	A1	SGM75HF12A1TFD	Carton

ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$, unless otherwise noted)

Characteristics		Symbol	Ratings	Units
Collector to Emitter Voltage		V_{CE}	1200	V
Gate to Emitter Voltage		V_{GE}	± 20	V
Collector Current	$T_c=80^\circ\text{C}$	I_c	75	A
Repetitive Pulsed Collector Current	$T_c=80^\circ\text{C}$	I_{CRM}	150	A
Operating Junction Temperature Range		T_J	-40 ~ +125	$^\circ\text{C}$
Storage Temperature Range		T_{stg}	-40 ~ +125	$^\circ\text{C}$
Isolation Voltage		V_{iso}	2500	V
To heat sink M6		M_s	3~5	Nm
To terminals M5		M_t	2.5~5	Nm
Weight		W	160	g



THERMAL CHARACTERISTICS

Characteristics	Symbol	Ratings	Units
Thermal Resistance, Junction to Case (IGBT)	R_{\thetaJC}	0.33	°C/W
Thermal Resistance, Junction to Case (FRD)	R_{\thetaJC}	0.56	°C/W
Thermal Resistance, Case to Sink	R_{\thetaCS}	0.03	°C/W

ELECTRICAL CHARACTERISTICS OF IGBT ($T_C = 25^\circ C$ unless otherwise noted)

Characteristics	Symbol	Test condition	Min.	Typ.	Max.	Unit
Collector-emitter saturation voltage	V_{CEsat}	$I_C=75A, V_{GE}=15V, T_j=25^\circ C$	--	2.2	2.8	V
		$I_C=75A, V_{GE}=15V, T_j=125^\circ C$	--	2.4	--	
		$I_C=75A, V_{GE}=15V, T_j=150^\circ C$	--	2.5	--	
Gate threshold voltage	V_{GEth}	$I_C=250\mu A, V_{CE}=V_{GE}, T_j=25^\circ C$	4.4	5.0	6.7	V
Collect-emitter cut-off current	I_{CES}	$V_{CE}=1200V, V_{GE}=0V, T_j=25^\circ C$	--	--	1	mA
G-E Leakage Current	I_{GES}	$V_{CE}=0V, V_{GE}=20V, T_j=25^\circ C$	--	--	500	nA
Integrated Gate Resistor	R_{Gint}	$T_j=25^\circ C$	--	4.8	--	Ω
Input Capacitance	C_{ies}	$f=1MHz, T_j=25^\circ C,$ $V_{CE}=25V, V_{GE}=0V$	--	4.79	--	nF
Output Capacitance	C_{oes}		--	0.72	--	
Reverse Transfer Capacitance	C_{res}		--	0.25	--	
Total Gate Charge	Q_G	$V_{GE}=-15V \text{---} +15V$	--	0.53	--	μC
Turn-on Delay Time	$t_{d(on)}$	$I_C=75A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=35\Omega$, Inductive load	$T_j=25^\circ C$	--	0.11	μs
Rise Time	t_r		$T_j=125^\circ C$	--	0.12	
Turn-off Delay Time	$t_{d(off)}$		$T_j=150^\circ C$	--	0.12	
Fall Time	t_f		$T_j=25^\circ C$	--	0.09	μs
Turn-on Switching Loss (per pulse)	E_{on}		$T_j=125^\circ C$	--	0.95	
Turn-Off Switching Loss (per pulse)	E_{off}		$T_j=150^\circ C$	--	0.10	
S-C Data	I_{SC}	$V_{GE}=15V, V_{CC}=600V, t_P \leq 10\mu s, T_j=25^\circ C$	--	420	--	A
Thermal Resistance : Junction-Case	R_{\thetaJC}	per IGBT	--	0.35	--	°C/W



Characteristics	Symbol	Test condition	Min.	Typ.	Max.	Unit
Temperature under on-state	T_{jop}		-40	--	125	°C

ELECTRICAL CHARACTERISTICS OF FRD ($T_c = 25^\circ\text{C}$ unless otherwise noted)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Units
Diode Forward Voltage	V_F	IF=75A, $V_{GE}=0\text{V}$, $T_c=25^\circ\text{C}$	--	2.1	--	V
		IF=75A, $V_{GE}=0\text{V}$, $T_c=125^\circ\text{C}$	--	1.7	--	
		IF=75A, $V_{GE}=0\text{V}$, $T_c=150^\circ\text{C}$	--	1.7	--	
Peak reverse Recovery current	I_{RM}		--	62	--	A
			--	88	--	
			--	109	--	
Recovery charge	Q_r	$I_f=75\text{A}$, $di/dt=710\text{A}/\mu\text{s}$, $V_R=600\text{V}$, $V_{GE}=-15\text{V}$	--	4.3	--	μC
			--	9.9	--	
			--	12.6	--	
Reverse recovery energy (per pulse)	E_{rec}		--	0.38	--	mJ
			--	1.40	--	
			--	1.76	--	
Thermal Resistance : Junction to Case	$R_{\theta JC}$	Per diode	--	0.69	--	K/W
Temperature under switching conditions	T_{Cop}		-40	--	125	°C

IGBT MODULE (MAXIMUM RATED VALUES) ($T_c = 25^\circ\text{C}$, unless otherwise noted)

Characteristics	Symbol	Test conditions	Ratings	Unit
Insulation test voltage	V_{ISOL}	RMS, $f=50\text{Hz}$, $t=1\text{min}$	2.5	kV
Material of module baseplate			Cu	
Material for internal insulation		Insulation (class1, IEC61140)	Al_2O_3	
Creepage distance		Terminal-heatsink	17	mm
		Terminal - terminal	20	
Clearance distance		Terminal-heatsink	17	mm
		Terminal - terminal	9.5	
Comparative tracking index	CTI		>200	



IGBT MODULE ELECTRICAL CHARACTERISTICS($T_c = 25^\circ\text{C}$, unless otherwise noted)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Stray inductance module	L_{sCE}		--	30	--	nH
Module lead resistance, terminal-chip	$R_{\text{CC'EE'}}$	$T_c = 25^\circ\text{C}$, per switch	--	0.65	--	mΩ
Storage temperature	T_{stg}		-40	--	125	°C
Mounting torque	M	Screw M6	3.0	--	5.0	Nm
Terminal connection torque	M	Screw M5	2.5	--	5.0	Nm
Weight	G		--	160	--	g

TYPICAL CHARACTERISTICS CURVE

Figure 1. Typical output characteristics

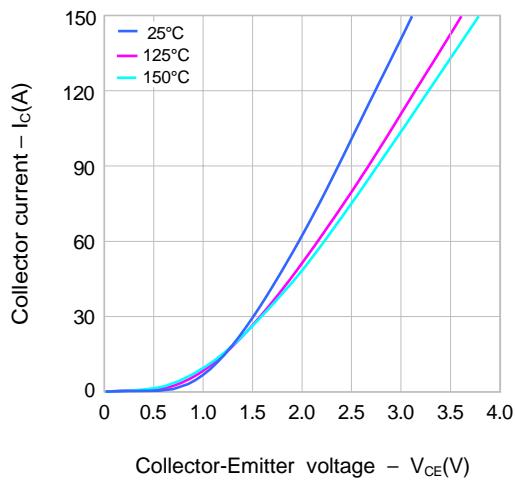


Figure 2. Typical output characteristics (150°C)

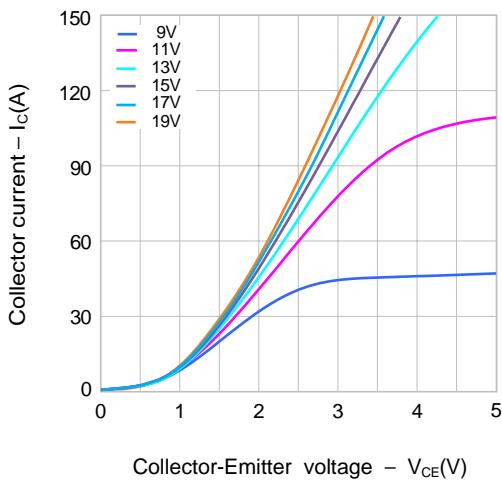


Figure 3. Transfer characteristics

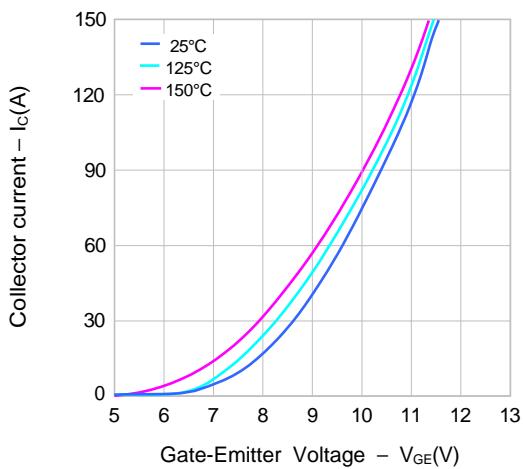


Figure 4. Switching Loss vs. Collector Current

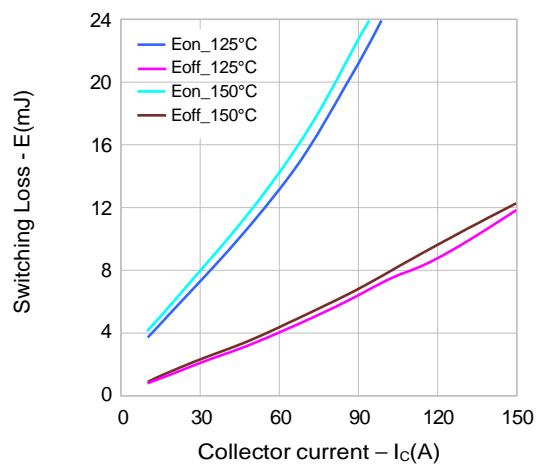


Figure 5. Switching loss vs. Gate resistance

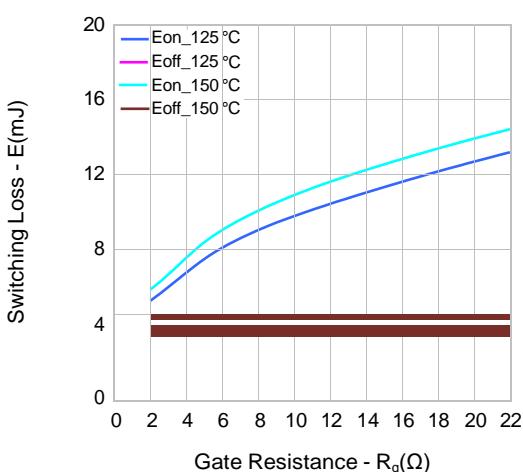
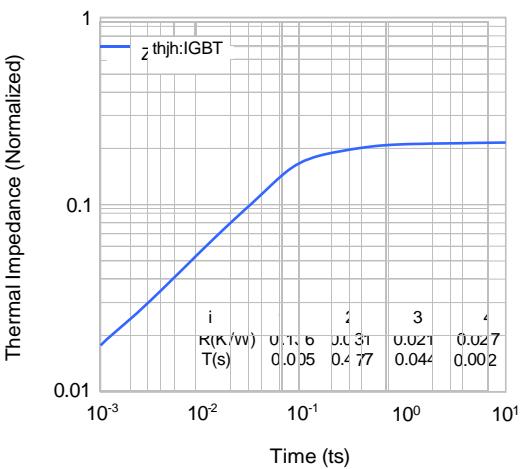


Figure 6. Transient Thermal Impedance





TYPICAL CHARACTERISTICS CURVE (continued)

Figure 7. Diode Forward Characteristics

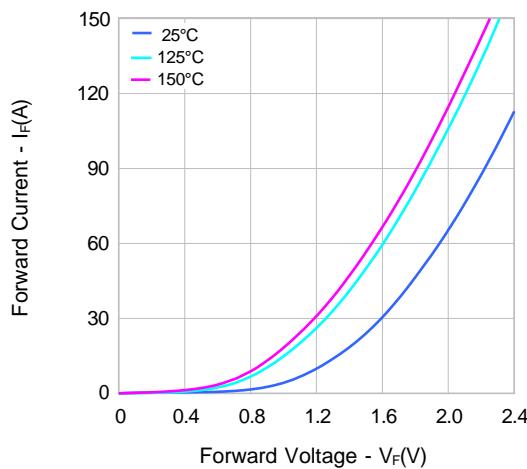


Figure 8. Switching Loss vs. Collector Current

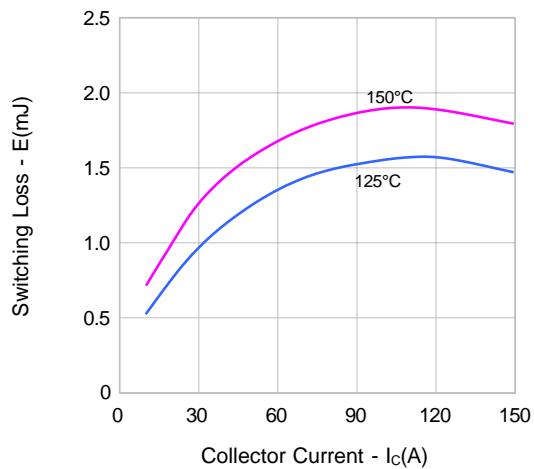


Figure 9. Switching Loss vs. Resistance

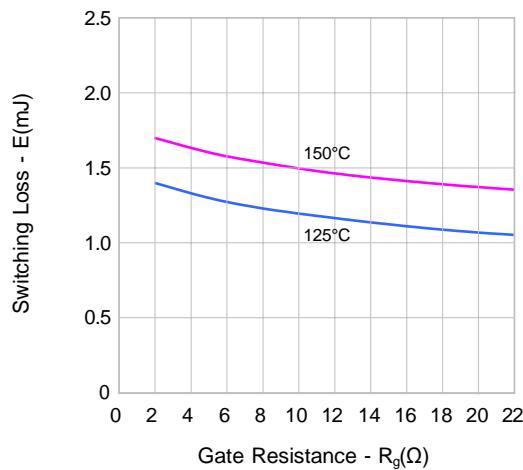
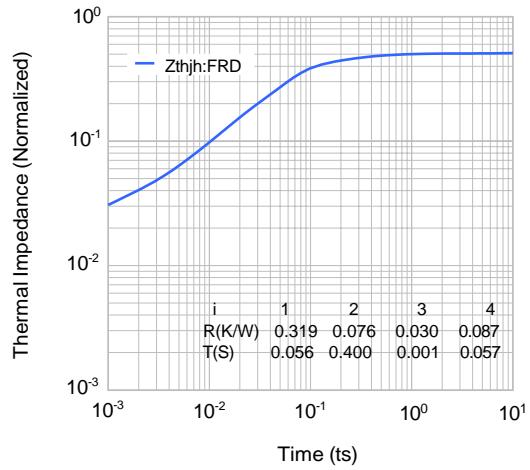
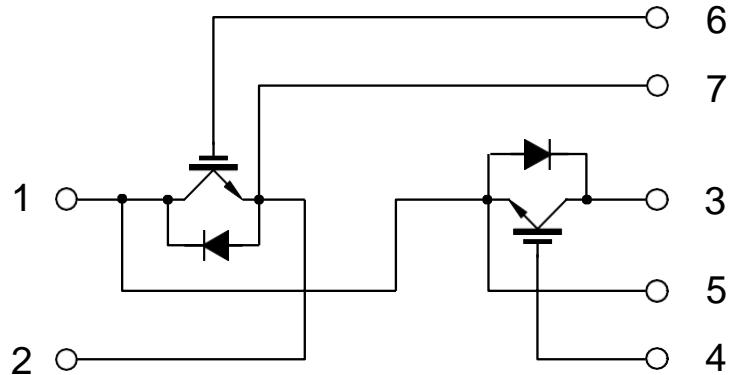


Figure 10. Transient Thermal Impedance

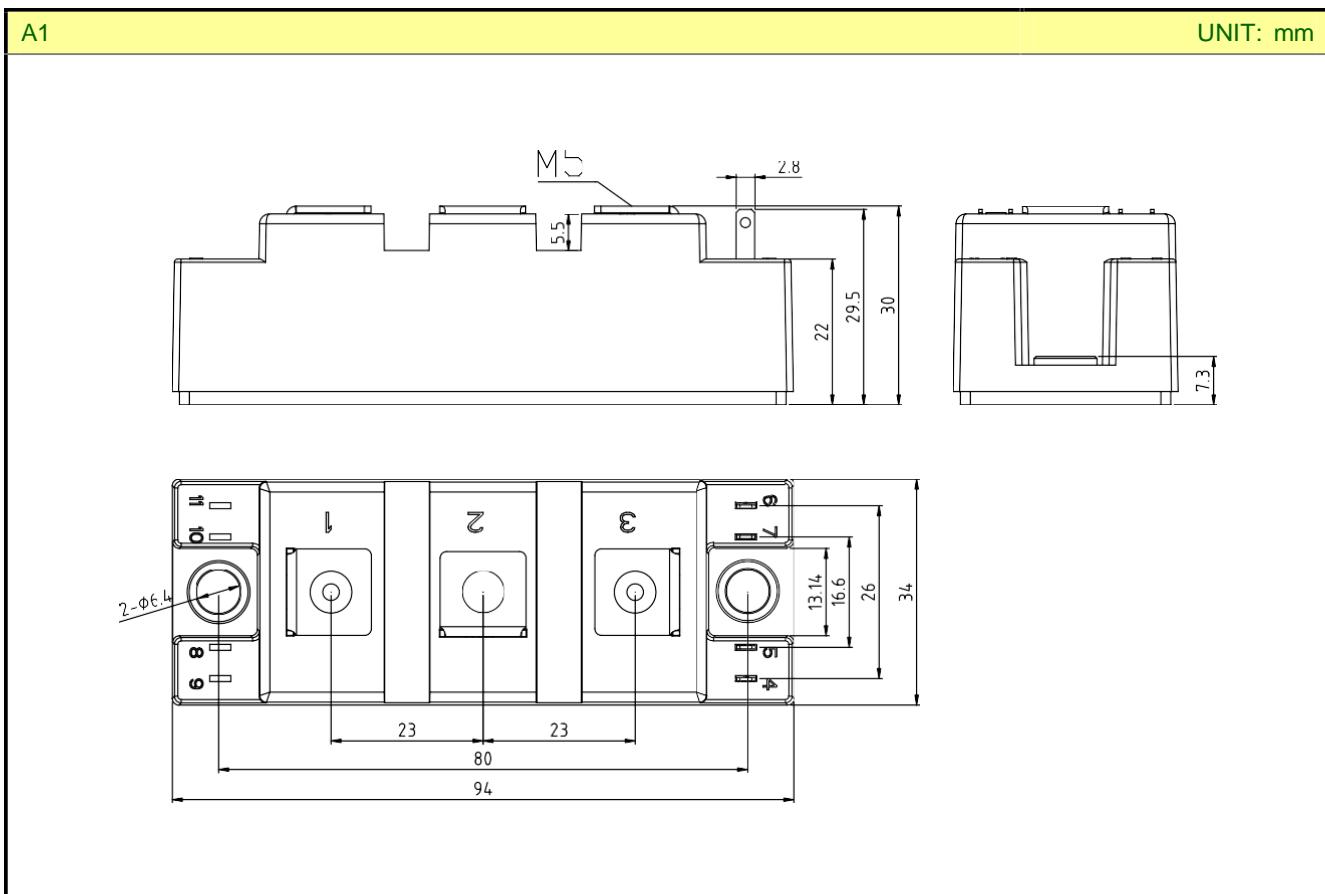


CIRCUIT DIAGRAM





PACKAGE OUTLINE



Disclaimer :

- Silan reserves the right to make changes to the information herein for the improvement of the design and performance without prior notice! Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current.
- All semiconductor products malfunction or fail with some probability under special conditions. When using Silan products in system design or complete machine manufacturing, it is the responsibility of the buyer to comply with the safety standards strictly and take essential measures to avoid situations in which a malfunction or failure of such Silan products could cause loss of body injury or damage to property.
- Silan will supply the best possible product for customers!



Part No.: SGM75HF12A1TFD

Document Type: Datasheet

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Rev.: 1.5

Revision History:

1. Modify the electric characteristics
 2. Update all curves
 3. Modify the package outline
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Rev.: 1.4

Revision History:

1. Modify the electric characteristics features description and curve
 2. Delete the “trench-gate” of nomenclature’s TF
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Rev.: 1.3

Revision History:

1. Modify the electric characteristics of IGBT
-

Rev.: 1.2

Revision History:

1. Modify the electric characteristics
-

Rev.: 1.1

Revision History:

1. Modify the electric characteristics of FRD
-

Rev.: 1.0

Revision History:

1. First release
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